

**DEVICE
ENGINEERING
INCORPORATED**

385 East Alamo Drive
Chandler, AZ 85225
Phone: (480) 303-0822
Fax: (480) 303-0824
E-mail: admin@deiaz.com

**DEI1270, DEI1271
DUAL ARINC 429 LINE DRIVER WITH
RATE SELECT and TRI-STATE**

FEATURES

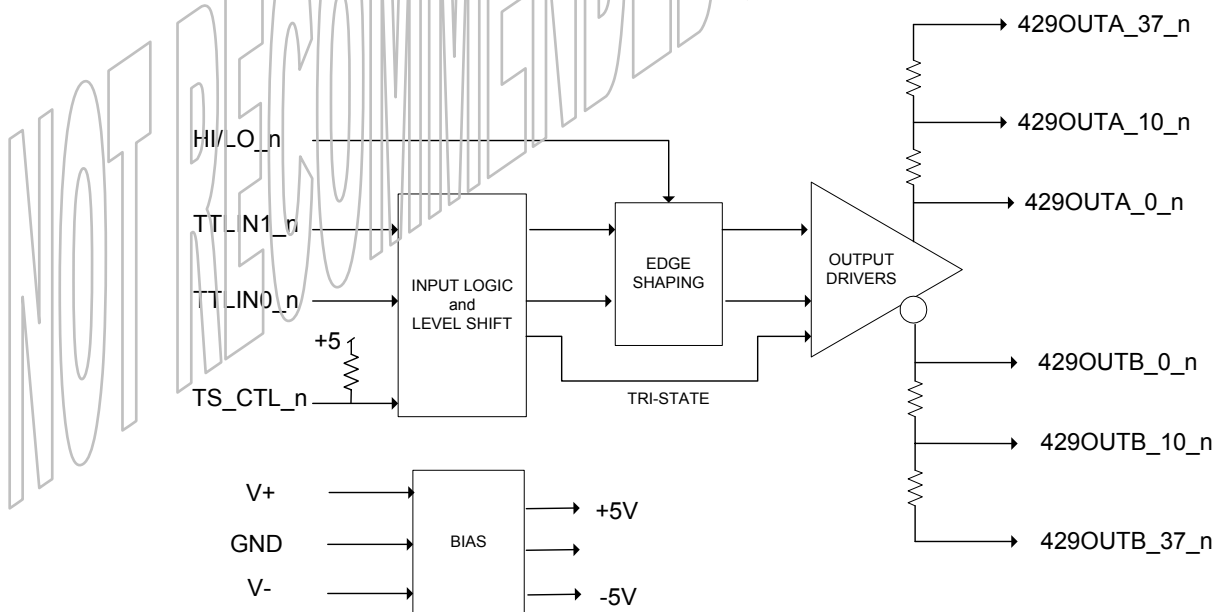
- Dual TTL/CMOS TO ARINC 429 Line Driver.
- Rate control input set Hi (100KBS) or Lo (12.5KBS) speed slew rates.
- Operates from $\pm 9.5V$ to $\pm 16.5V$ power supply.
- Drives full ARINC load.
- Tri-State A429 output feature
- 0, 10 and 37.5 Ohm output resistor taps
- Packages: thermally enhanced 5 x 7 mm MLP
- Outputs Short Circuit Tolerant

GENERAL DESCRIPTION

The DEI1270 family BiCMOS integrated circuits are dual line drivers designed to directly drive the ARINC 429 avionics serial digital data bus. The device converts TTL/CMOS serial input data to the tri-level RZ bipolar differential modulation format of the ARINC bus. A TTL/CMOS control input selects the output slew rate for HI (100KBS) and LOW (12.5KBS) speed operation. No external timing capacitors are required. A429 output tri-state capability is enabled by the TS_CTL input.

The exposed pad heatsink of the DEI1270 is connected to V- power supply. The DEI1271 exposed pad is electrically isolated.

FUNCTION DIAGRAM

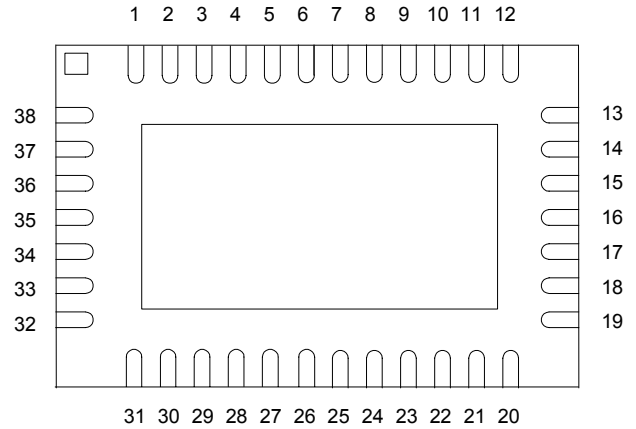


One of two channels shown

TERMINAL DESCRIPTION

Notes:

1. Package: 38 Lead 5.0 x 7.0mm MLP
2. Exposed Pad is connected V- Supply on DEI1270.
Exposed Pad is electrically isolated on DEI1271.



BOTTOM VIEW

Table 1 Pin Description

SIGNAL NAME	Channel 1 Pin	Channel 2 Pin	DESCRIPTION
HI/LO_n	5	24	LOGIC INPUT. Slew rate control. 1 = Hi speed. 0 = Low speed.
TTLIN0_n	6	25	LOGIC INPUT. Serial digital data input 0.
TTLIN1_n	26	7	LOGIC INPUT. Serial digital data input 1.
TS_CTL_n	27	8	LOGIC INPUT. Open or '1' disables output Tristate function. '0' Enables output Tristate function.
429OUTA_0_n	34	15	429 OUTPUT. ARINC 429 format serial digital data output A, 0 Ohm
429OUTA_10_n	33	14	429 OUTPUT. ARINC 429 format serial digital data output A, 10 Ohm
429OUTA_37_n	32	13	429 OUTPUT. ARINC 429 format serial digital data output A, 37 Ohm
429OUTB_0_n	36	17	429 OUTPUT. ARINC 429 format serial digital data output B, 0 Ohm
429OUTB_10_n	37	18	429 OUTPUT. ARINC 429 format serial digital data output B, 10 Ohm
429OUTB_37_n	38	19	429 OUTPUT. ARINC 429 format serial digital data output B, 37 Ohm
V+	2	20	POWER INPUT. +9.5 to +16.5 VDC.
GND	28	9	POWER INPUT. Ground.
V-	30	12	POWER INPUT. -9.5 to -16.5 VDC
NC	1,3,4,10,11, 16, 21, 22, 23, 29, 31,35		No Internal Connect

FUNCTIONAL DESCRIPTION

Table 2 Speed Control Function Table

HI/LO_n	OUTPUT TRANSITION TIME
0	10uS (12.5 KBS data)
1	1.5uS (100KBS data)

Table 3 Transmit Data Function Table

TS_CTL_n	TTLIN1_n	TTLIN0_n	429OUTA	429OUTB	NOTES
X	0	0	0V	0V	Null output
X	0	1	-5V	5V	Zero output
X	1	0	5V	-5V	One output
1	1	1	0V	0V	Null output
0	1	1	Hi-Z	Hi-Z	Tri-state Output

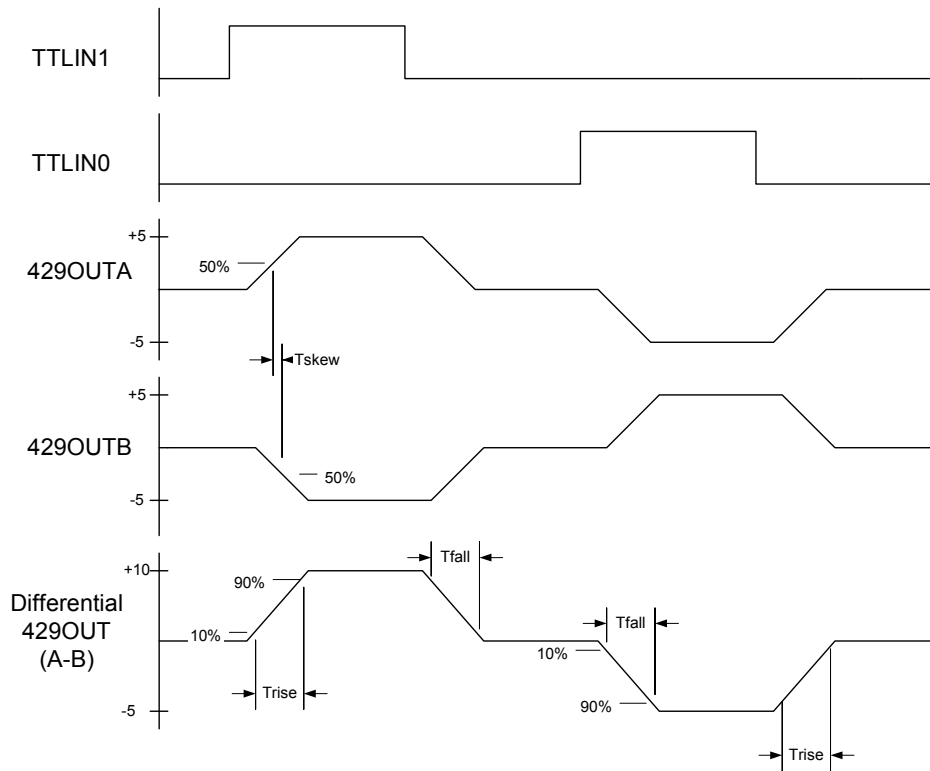


Figure 1 Timing Waveforms

ELECTRICAL DESCRIPTION

Table 4 Absolute Maximum Ratings

PARAMETER	MIN	MAX	UNITS
Voltages referenced to Ground			
V+ Supply Voltage	-0.3	+20	V
V- Supply Voltage	0.3	-20	V
V+, V- Supply Slew Rate		+/-100	V/uS
Storage Temperature	-65	+150	°C
Input Voltage TTLIN , HI/LO, and TS_CTL Inputs 429OUT Outputs	Gnd – 0.3 'V-' – 0.3	'V+' + 0.3 'V+' + 0.3	V V
Power Dissipation @ 85 °C: (> 10 Sec) 38 Lead MLQ, thermal pad soldered to heat spreader land.		1.5	W
Junction Temperature: Tjmax, Plastic Packages (Limited by molding compound Tg)		145	°C
ESD per JEDEC A114-A Human Body Model		2000	V
Peak body Soldering Temperature (10 sec duration)		235	°C
Notes:			
1. Stresses above absolute maximum ratings may cause permanent damage to the device.			
2. The device is tolerant of one or both outputs shorted to Ground and of both outputs shorted together.			

Table 5 Recommended Operating Conditions

PARAMETER	SYMBOL	CONDITIONS
Supply Voltage	V+ V-	9.5 to 16.5V -9.5 to -16.5V
Operating Temperature Plastic Package	T _{OP}	-55 to +85 °C

Table 6 Electrical Characteristics

Conditions: Temperature: -55°C to +85°C. V+/- = +/-9.5 to +/-16.5V Unless otherwise noted.						
PARAMETER	TEST CONDITION	SYMBOL	MIN	NOM	MAX	UNITS
LOGIC INPUTS						
Input Voltage, Logic 1		V _{IH}	2.0		V+	V
Input Voltage, Logic 0		V _{IL}	-0.3		0.8	V
Input Current, Logic 1	V _{IN} = 5.0V	I _{IH}	0		100	uA
Input Current, Logic 0	V _{IN} = 0.0V TS_CTL All Others	I _{IL}	0		-250	uA
			0		-100	uA
ARINC OUTPUTS						
ARINC Output Voltage (Differential) One Null Zero	Differential Output Voltage = 429OUTA – 429OUTB. No Load.	V _{DIF1}	9.0	10.0	11.0	V
		V _{DIFnull}	-0.5	0	+0.5	V
		V _{DIF0}	-9.0	-10.0	-11.0	V
ARINC Output Voltage (Single Ended) Hi Null Lo	Referenced to Ground No Load.	V _{OHI}	4.5	5.0	5.5	V
		V _{Onull}	-0.25	0	+0.25	V
		V _{OLO}	-5.5	-5.0	-4.5	V
Output Tristate Current	-5V to +5V	I _Z	-10		+10	uA
ARINC Output Short Circuit Current	Outputs shorted to Ground.	I _{SCLO}		130		mA
		I _{SCH}		-130		mA
Output Resistance: 429OUT_37 429OUT_10 429OUT_0	Room Temperature	R _{out}		37.5		Ohms
				10		Ohms
				0		Ohms
Output Slew Rate Hi Speed	HI/LO = 1 No Load 10% to 90% voltage amplitude of differential output.	T _{rise}	1.0		2.0	uS
		T _{fall}				
Output Slew Rate Lo Speed	HI/LO = 0 No Load 10% to 90% voltage amplitude of differential output.	T _{rise}	5		15	uS
		T _{fall}				
Output skew time between A and B outputs.	HI/LO = 1 Measured at 50% voltage amplitude of both outputs.	T _{skew}			200	nS
SUPPLY CURRENT						
Quiescent Operating Supply Current, per channel. IV+ IV-	V+ = 15V, V- = -15V HI/LO = 0 or 1 TTLIN0=TTLIN1= 0V No Load	I _{V+} I _{V-}	-	6.0	14.0	mA
			-14.0	-6.0	-	mA

DESIGN CONSIDERATIONS

Transient Voltage Protection

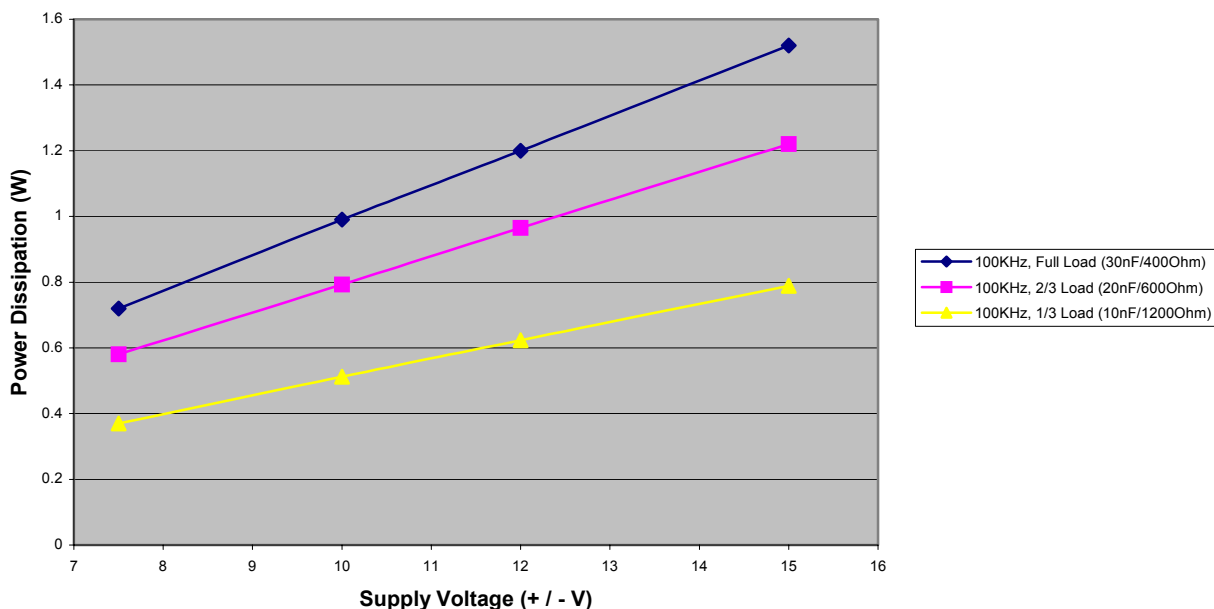
External transient voltage suppressing devices are required to protect the device from stress such as that defined by DO160D Section 22, Lightning Induced Transient Susceptibility. The output stage of the driver includes intrinsic clamp diodes to the V+ and V- power rails. Consider using the 0 Ohm output option to allow use of an external 36 Ohm current limiting resistor and transient voltage suppressor. Transients at the device must be limited to less than one diode drop beyond the power rails to prevent excessive current to the device.

Thermal Management

Device power dissipation varies greatly as a function of data rate, load capacitance, data duty cycle, and supply voltage. Proper thermal management is important in designs operating at the HI speed data rate (100KBS) with high capacitive loads and high data duty cycles. Dissipation may be estimated from the graph below which shows the approximate power dissipation for various loads and supply voltages. It is calculated for 100% data duty cycle at 100KBS with no word gap null times and must be reduced by the appropriate data duty cycle. Adjust for the application data duty cycle using a factor of (total bits transmitted in 10 sec period / 1,000,000) = (32 x total ARINC words transmitted in 10 sec period / 1,000,000).

Heat transfer from the IC package should be maximized. Use maximum trace width on all power and signal connections at the IC. The exposed heat sink pad of the MLP package should be soldered to a heat spreader land on the PCB. The DEI1271 pad is electrically isolated. The DEI1270 pad is internally connected to the V- supply voltage. Place vias on the signal/power traces close to the IC and on the heat spreader land to maximize heat flow to the internal power planes.

429 DRIVER DEVICE POWER DISSIPATION (100kbs, 100% DC)



PACKAGE DESCRIPTIONS

38 Lead 5.0 x 7.0 MLP

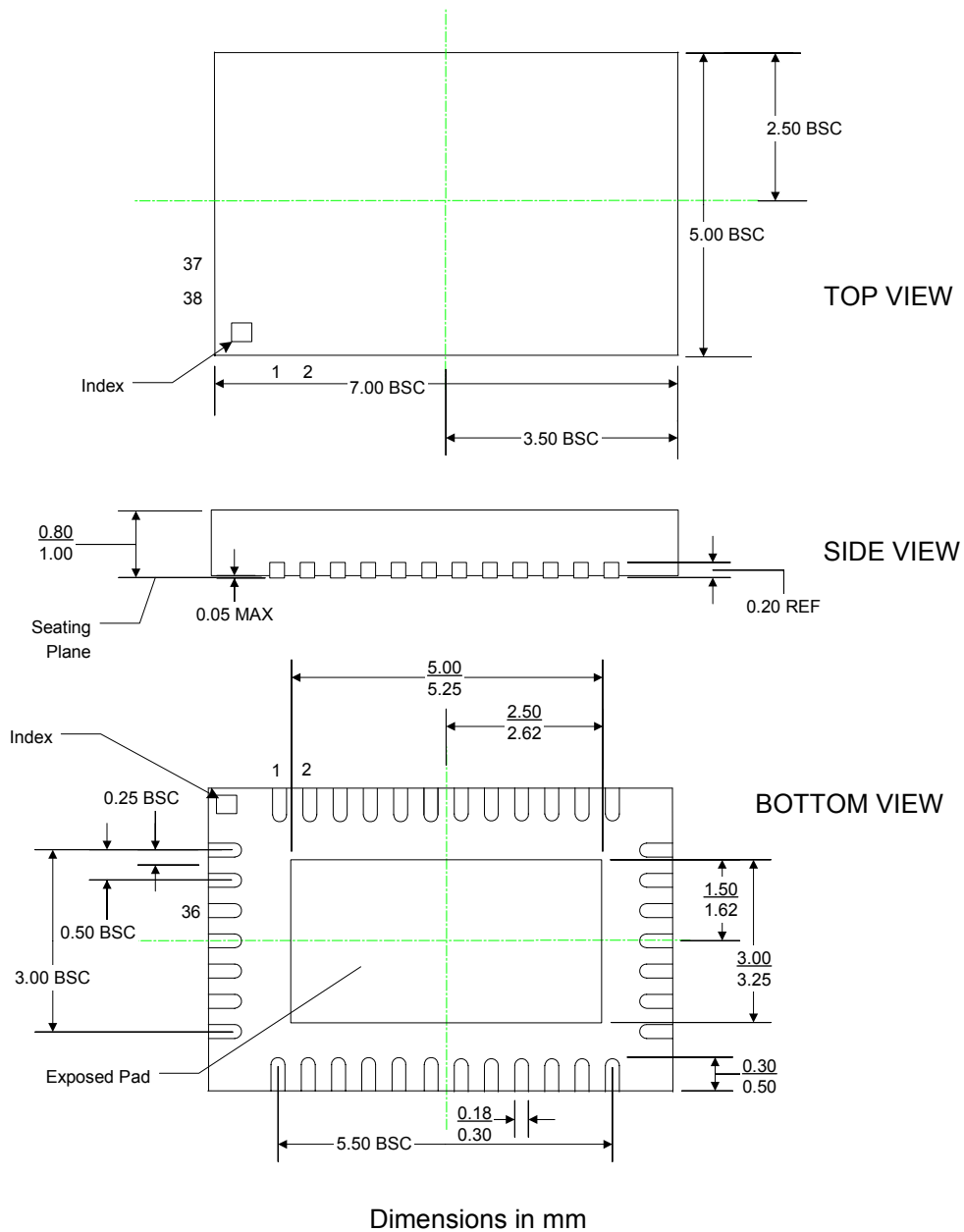


Table 7 38L MLP Characteristics

SYMBOL	DESCRIPTION	VALUE	UNITS
Theta _{ja}	Junction to Ambient. DEI1270 - Conductive pad DEI1271 - Isolated Pad 4 layer board with 2 internal power planes. Exposed pad soldered to .110" x .220" land with vias.	~34 ~40	°C/W
MSL	JEDEC Moisture Sensitivity Level Peak Body Temperature	2 235	- °C

ORDERING INFORMATION

<u>Part Number</u>	<u>Marking</u>	<u>Package</u>	<u>Temperature</u>
DEI1270-MES	DEI1270MES	38L MLP - conductive	-55 / +85 °C
DEI1271-MES	DEI1271MES	38L MLP- isolated	-55 / +85 °C

DEI reserves the right to make changes to any products or specifications herein. DEI makes no warranty, representation, or guarantee regarding suitability of its products for any particular purpose.